Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/612,134	DAESCHLE ET AL.
Examiner	Art Unit
Anthony D. Barfield	3636

	SEARCHED					
Class	Subclass	Date	Examiner			
297	300,7	10/2/05	B			
	300.8	10/2/05	AS			
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
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